

400V N-Channel MOSFET

Description

The MSD4N40 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-252 package is universally preferred for all commercial-industrial applications

Features

- · Originative New Design
- 100% EAS Test
- · Rugged Gate Oxide Technology
- Extremely Low Intrinsic Capacitances
- · Remarkable Switching Characteristics
- Unequalled Gate Charge: 25 nC (Typ.)
- · Extended Safe Operating Area
- Lower RDS(ON): 0.78 Ω (Typ.) @VGS=10V
- · RoHS compliant package

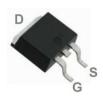
Application

- · Low power battery chargers
- Switch mode power supply (SMPS)
- DC-AC converters.

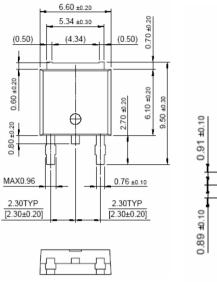
Packing & Order Information

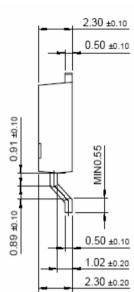
Part No./ R: 2,500/Reel

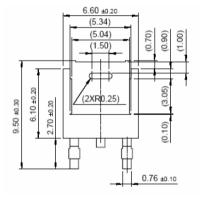
Part No./ T: 80/Tube, 4,000/Box



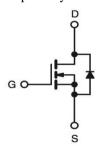
RoHS COMPLIANT







Graphic symbol



MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)						
Symbol	Parameter	Value Unit				
$V_{\rm DSS}$	Drain-Source Voltage	400	V			
V _{GS}	Gate-Source Voltage	±30	V			
I_{D}	Continuous Drain Current (TC=25°C)	4.5	A			
	Continuous Drain Current (T _C =100°C)	3.0	A			



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Absolute Maximum Ratings (Tc=25°C unless otherwise noted)						
Symbol	Parameter	Value	Unit			
I_{DM}	Pulsed Drain Current	22	A			
EAS	Single Pulsed Avalanche Energy	270	mJ			
EAR	Repetitive Avalanche Energy	7.3	mJ			
dV/dt	Peak Diode Recovery dV/dt	4.5	V/ns			
D	Power Dissipation (T _C =25°C)	2.5	W			
P_D	- Derate above 25°C	0.38	W			
T _J /T _{STG}	Operating Junction and Storage Temperature	-55 to +150	°C			
$T_{ m L}$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C			

[•]Drain current limited by maximum junction temperature

Thermal Resistance Characteristics (Tc=25°C unless otherwise noted)						
Symbol	Parameter	Typ.	Max.	Units		
Rөлс	Junction-to-Case		1.72	°C/W		
RөJA	Junction-to- Ambient		83.3	C/W		

On Characteristics							
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units	
V_{GS}	Gate Threshold Voltage	$V_{DS} = V_{GS} \; , \; I_D = 250 \mu A \;$	2.0		4.0	V	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 2.25 \text{ A}$		0.78	0.9	Ω	

Off Characteristics						
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units
$\mathrm{BV}_{\mathrm{DSS}}$	Drain-Source Breakdown Voltage	$V_{\rm GS} = 0 \ V$, I_D =250 μ A	400			V
ΔBV_{DSS} $/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25 $^{\circ}$ C		0.54		V/°C
Idss	Zero Gate Voltage Drain Current	$V_{DS} = 400 \ V \ , \ V_{GS} = 0 \ V \ \\ V_{DS} = 320 \ V \ , \ T_C = 125 \ ^{\circ}C$			1 10	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS}=30\ V$, $V_{DS}=0\ V$			100	nA
Igssr	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA



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Dynamic	Dynamic Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units		
$C_{\text{IS}\text{S}}$	Input Capacitance			480	625	pF		
Coss	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ F = 1.0 MHz		80	105	pF		
C_{RSS}	Reverse Transfer Capacitance	I' = 1.0MIZ		15	20	pF		
$t_{d(on)}$	Turn-On Time			15	35	ns		
$t_{\rm r}$	Turn-On Time	$V_{DS} = 200 \text{ V}, I_D = 4.5 \text{ A},$		65	140	ns		
$t_{d(off)}$	Turn-Off Delay Time	$R_G = 25 \Omega$		23	55	ns		
tf	Turn-Off Fall Time			40	85	ns		
Qg	Total Gate Charge			16	20	nC		
Q_{gs}	Gate-Source Charge	$V_{DS} = 320 \text{ V}, I_D = 4.5 \text{ A},$		2.3		nC		
Q_{gd}	Gate-Drain Charge	$V_{GS} = 10 \text{ V}$		8.5		nC		

Source-Drain Diode Maximum Ratings and Characteristics								
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units		
Is	Continuous Source-Drain Diode Forwa	rd Current			4.5			
I _{SM}	Pulsed Source-Drain Diode Forward Current				18	A		
V _{SD}	Source-Drain Diode Forward Voltage	$I_S = 4.5 A, V_{GS} = 0 V$			1.4	V		
t _{rr}	Reverse Recovery Time	$I_S = 4.5 \text{ A}, V_{GS} = 0 \text{ V}$		230		ns		
Qrr	Reverse Recovery Charge	$diF/dt = 100A/\mu s$		1.7		μC		

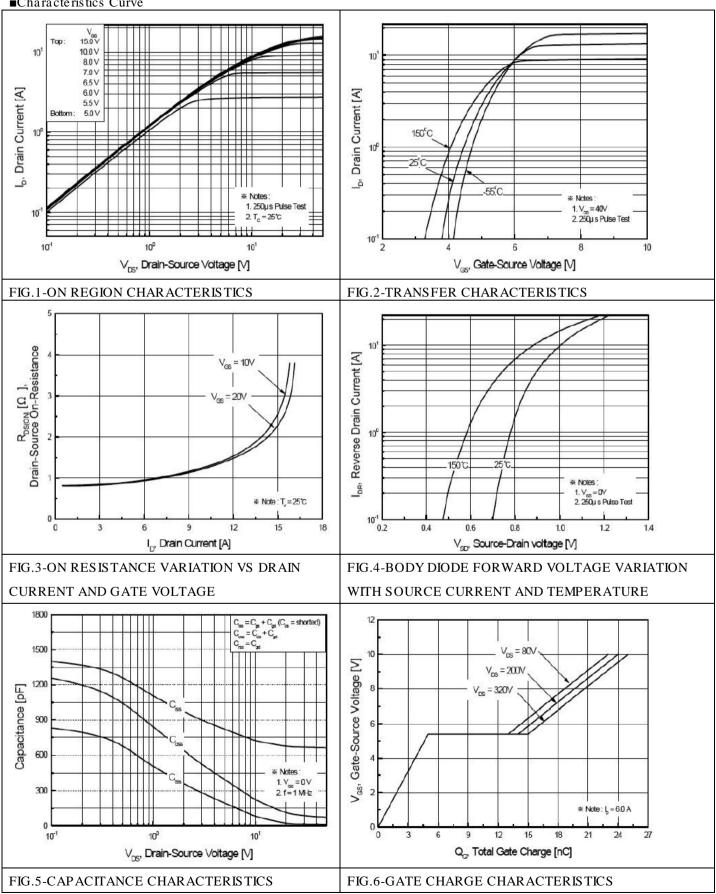
NOTE:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} =4.5A, V_{DD} =50V, R_G =25 Ω , Starting TJ =25 $^{\circ}$ C
- 3. $I_{SD}\le4.5A$, di/dt $\le300A/\mu s$, VDD \leBVDSS , Starting TJ =25 °C
- 4. Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%
- 5. Essentially Independent of Operating Temperature



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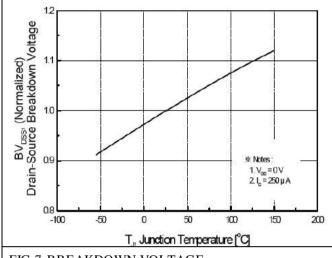
■Characteristics Curve





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■Characteristics Curve



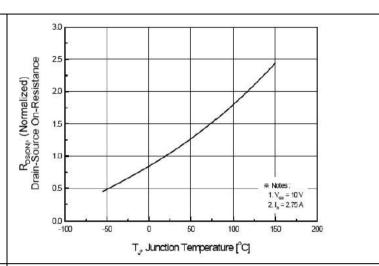


FIG.7-BREAKDOWN VOLTAGE VARIATION VS TEMPERATURE

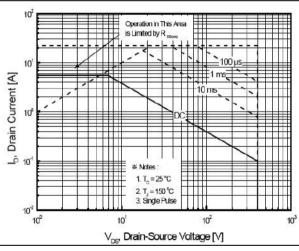


FIG.8-ON-RESISTANCE VARIATION VS TEMPERATURE

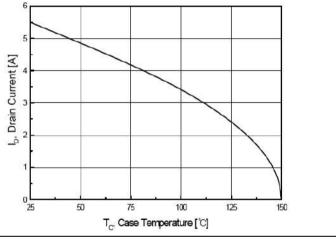


FIG.9-MAXIMUM SAFE OPERATING AREA

 $\begin{aligned} & \textbf{FIG.10-MAXIMUM DRAIN CURRENT VS CASE} \\ & \textbf{TEMPERATURE} \end{aligned}$

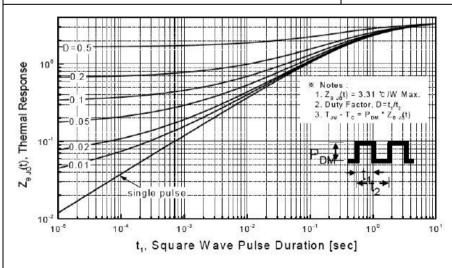


FIG.11-TRANSIENT THERMAL RESPONSE CURVE



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■Characteristics Test Circuit & Waveform

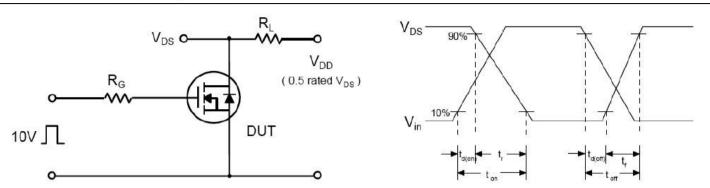


Fig 12. Resistive Switching Test Circuit & Waveforms

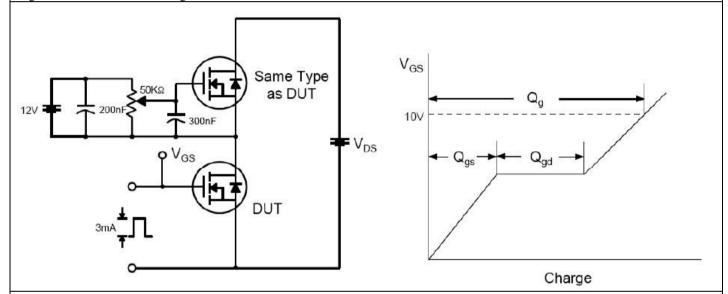
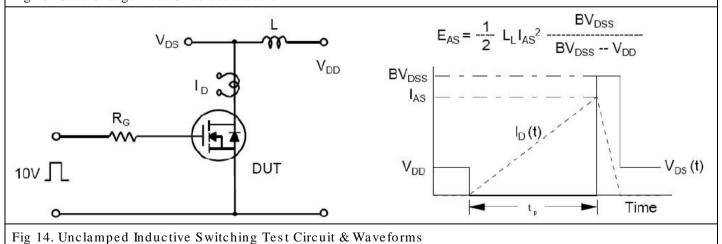


Fig 13. Gate Charge Test Circuit & Waveform





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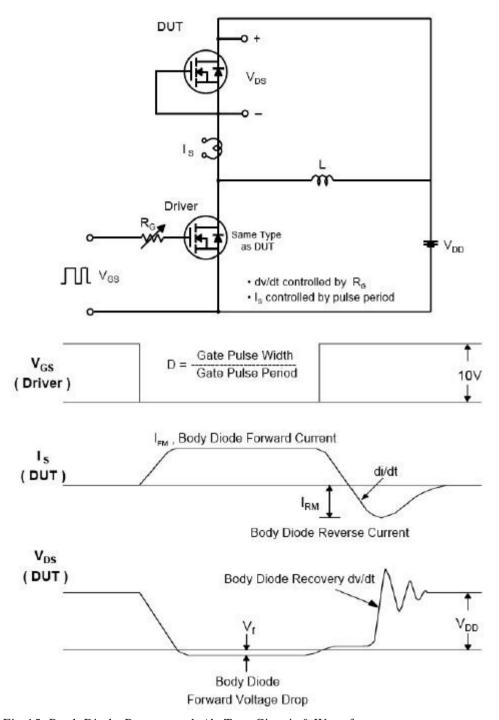


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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